

**Issue Classification**

Application/Control No.

10521610

Applicant(s)/Patent Under Reexamination

IWAKI ET AL.

Examiner

Cruz, Magda

Art Unit

2851

**ORIGINAL**

CLASS

SUBCLASS

359

457

**INTERNATIONAL CLASSIFICATION**

CLAIMED

NON-CLAIMED

G

0

3

B

21 / 60 (2006.01.01)

G

0

3

B

21 / 56 (2006.01.01)

**CROSS REFERENCE(S)**

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

359

456

457

460

Cruz, Magda  
(Assistant Examiner)01/14/2008  
(Date)DIANE I. LEE  
SUPERVISORY PATENT EXAMINER

Total Claims Allowed:

12

Diane Lee  
(Primary Examiner)1/17/08  
(Date)

O.G. Print Claim(s)

1

O.G. Print Figure

3